Search Notes		

Application/Control No.	Applicant(s)/Patent und Reexamination	er
09/537,367	SAWANO, TAKASHI	
Examiner	Art Unit	
CHAN S. PARK	2622	

SEARCHED				
Class	Subclass	Date	Examiner	
35B	1.15, 1.16 1.17,404, 444, 437	1/12/05	СР	
			,	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
358/1.15	, 1.16 , 1.17 , 4444 , 487	10/20/05	СР

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East (see the search history)	5/4/2005	СР